


<b>Search Notes</b> 	<b>Application/Control No.</b> 10563768	<b>Applicant(s)/Patent Under Reexamination</b> MATSUDA, KOUICHI
	<b>Examiner</b> DANIEL TEKLE	<b>Art Unit</b> 2621

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
EAST SEARCH DATA BASE (USPGPUB; USPAT; EPO; JPO; DERWENT; USOCR)	03/25/09	D.T.
SEARCH QUERY ATTACHED	03/25/09	D.T.
INVENTOR SEARCH	03/25/09	D.T.
NPL	03/25/09	D.T.
SEARCH UPDATED	06/25/09	D.T.
SEARCH UPDATED	12/04/09	DT.
SEARCH UPDATED	02/12/10	D.T.
SEARCH UPDATED	07/29/10	D.T.
SEARCH UPDATED	10/13/10	D.T.
INVENTOR SEARCH	10/13/10	D.T.
386\$(TEXT SEARCH)		

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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Examiner,Art Unit 2621